

FCC TEST REPORT

REPORT NO.: RF120619E04

MODEL NO.: T-R0003

FCC ID: JNZTR0003

RECEIVED: June 19, 2012

TESTED: June 20 to July 11, 2012

ISSUED: July 19, 2012

APPLICANT: LOGITECH FAR EAST LTD.

ADDRESS: #2 Creation Rd. 4, Science-Based Ind. Park Hsinchu Taiwan, R.O.C.

- **ISSUED BY:** Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch Hsin Chu Laboratory
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TABLE OF CONTENTS

RELEAS	E CONTROL RECORD	4
1	CERTIFICATION	
2	SUMMARY OF TEST RESULTS	6
2.1	MEASUREMENT UNCERTAINTY	
3	GENERAL INFORMATION	
3.1	GENERAL DESCRIPTION OF EUT	8
3.2	DESCRIPTION OF TEST MODES	
3.3	TEST MODE APPLICABLITY AND TESTED CHANNEL DETAIL:	-
3.4	GENERAL DESCRIPTION OF APPLIED STANDARDS	
3.5	DESCRIPTION OF SUPPORT UNITS	
3.6	CONFIGURATION OF SYSTEM UNDER TEST	
4	TEST PROCEDURES AND RESULTS	
4.1	CONDUCTED EMISSION MEASUREMENT	
4.1.1	LIMITS OF CONDUCTED EMISSION MEASUREMENT	.14
4.1.2	TEST INSTRUMENTS	
4.1.3	TEST PROCEDURES	.15
4.1.4	TEST SETUP	.15
4.1.5	EUT OPERATING CONDITIONS	.16
4.1.6	TEST RESULTS	
4.2	RADIATED EMISSION AND BANDEDGE MEASUREMENT	
4.2.1	LIMITS OF RADIATED EMISSION AND BANDEDGE MEASUREMENT	.19
4.2.2	TEST INSTRUMENTS	.20
4.2.3	TEST PROCEDURES	.21
4.2.4	DEVIATION FROM TEST STANDARD	.21
4.2.5	TEST SETUP	.22
4.2.6	EUT OPERATING CONDITIONS	.22
4.2.7	TEST RESULTS	.23
4.3	NUMBER OF HOPPING FREQUENCY USED	27
4.3.1	LIMIT OF HOPPING FREQUENCY USED	.27
4.3.2	TEST INSTRUMENTS	.27
4.3.3	TEST PROCEDURES	.27
4.3.4	DEVIATION FROM TEST STANDARD	.27
4.3.5	TEST SETUP	.28
4.3.6	TEST RESULTS	.28
4.4	DWELL TIME ON EACH CHANNEL	29
4.4.1	LIMIT OF DWELL TIME USED	.29
4.4.2	TEST INSTRUMENTS	.29
4.4.3	TEST PROCEDURES	.29
4.4.4	DEVIATION FROM TEST STANDARD	
4.4.5	TEST SETUP	
4.4.6	TEST RESULTS	

4.5 CHANNEL BANDWIDTH. 32 4.5.1 LIMITS OF CHANNEL BANDWIDTH. 32 4.5.2 TEST INSTRUMENTS. 32 4.5.3 TEST PROCEDURE. 32 4.5.4 DEVIATION FROM TEST STANDARD. 32 4.5.5 TEST SETUP 33 4.5.6 EUT OPERATING CONDITION. 33 4.5.7 TEST RESULTS 34 4.6 HOPPING CHANNEL SEPARATION. 35 4.6.1 LIMIT OF HOPPING CHANNEL SEPARATION. 35 4.6.2 TEST INSTRUMENTS. 35 4.6.3 TEST PROCEDURES. 35 4.6.4 DEVIATION FROM TEST STANDARD. 35 4.6.5 TEST SETUP 35 4.6.6 TEST RESULTS. 36 4.6.7 TEST RESULTS 36 4.6.6 TEST RESULTS 36 4.7 MAXIMUM PEAK OUTPUT POWER 37 4.7.1 LIMITS OF CONDITION. 37 4.7.2 INSTRUMENTS. 37 4.7.4 DEVIATION FROM TEST STANDARD. 37 4.7.1 LIMITS OF MAXIMUM PEAK OUTPUT POWER			1828
4.5.1LIMITS OF CHANNEL BANDWIDTH			A D T
4.5.2TEST INSTRUMENTS324.5.3TEST PROCEDURE324.5.4DEVIATION FROM TEST STANDARD324.5.5TEST SETUP334.5.6EUT OPERATING CONDITION334.5.7TEST RESULTS344.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.	-	-	-
4.5.3TEST PROCEDURE324.5.4DEVIATION FROM TEST STANDARD324.5.5TEST SETUP334.5.6EUT OPERATING CONDITION334.5.7TEST RESULTS344.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST SETUP354.6.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD384.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION404.8.6EUT OPERATING CONDITION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A			-
4.5.4DEVIATION FROM TEST STANDARD324.5.5TEST SETUP334.5.6EUT OPERATING CONDITION334.5.7TEST RESULTS344.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST NSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPEND			
4.5.5TEST SETUP334.5.6EUT OPERATING CONDITION334.5.7TEST RESULTS344.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST RESULTS364.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE </td <td></td> <td></td> <td>-</td>			-
4.5.6EUT OPERATING CONDITION334.5.7TEST RESULTS.344.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES.354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS.364.7MAXIMUM PEAK OUTPUT POWER.374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT.374.7.2INSTRUMENTS374.7.3TEST PROCEDURES.374.7.4DEVIATION FROM TEST STANDARD.374.7.5TEST SETUP.384.7.6EUT OPERATING CONDITION.384.7.7TEST RESULTS.394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.3TEST PROCEDURE.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.6EUT OPERATING CONDITION.404.8.7TEST RESULTS.415PHOTOGRAPHS OF THE TEST CONFIGURATION.436INFORMATION ON THE TESTING LABORATORIES.447APPENDIX A - MODIFICATIONS RECOR			
4.5.7TEST RESULTS	4.5.5		
4.6HOPPING CHANNEL SEPARATION354.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.4DEVIATION FROM TEST STANDARD404.8.7TEST PROCEDURE404.8.8TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.7TEST SETUP404.8.8TEST SETUP404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LAB	4.5.6	EUT OPERATING CONDITION	33
4.6.1LIMIT OF HOPPING CHANNEL SEPARATION354.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST STANDARD404.8.7TEST SETUP404.8.7TEST SETUP404.8.7TEST SETUP404.8.7TEST SETUP404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.5.7	TEST RESULTS	34
4.6.2TEST INSTRUMENTS354.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6	HOPPING CHANNEL SEPARATION	35
4.6.3TEST PROCEDURES354.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6.1	LIMIT OF HOPPING CHANNEL SEPARATION	35
4.6.4DEVIATION FROM TEST STANDARD354.6.5TEST SETUP354.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6.2	TEST INSTRUMENTS	35
4.6.5TEST SETUP	4.6.3	TEST PROCEDURES	35
4.6.6TEST RESULTS364.7MAXIMUM PEAK OUTPUT POWER374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST SETUP404.8.6TEST SETUP404.8.7TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6.4	DEVIATION FROM TEST STANDARD	35
4.7MAXIMUM PEAK OUTPUT POWER.374.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT.374.7.2INSTRUMENTS.374.7.3TEST PROCEDURES.374.7.4DEVIATION FROM TEST STANDARD.374.7.5TEST SETUP.384.7.6EUT OPERATING CONDITION.384.7.7TEST RESULTS.394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.2TEST INSTRUMENTS.404.8.3TEST PROCEDURE.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.6EUT OPERATING CONDITION.404.8.7TEST SETUP.404.8.6EUT OPERATING CONDITION.404.8.7TEST RESULTS.415PHOTOGRAPHS OF THE TEST CONFIGURATION.436INFORMATION ON THE TESTING LABORATORIES.447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6.5	TEST SETUP	35
4.7.1LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT374.7.2INSTRUMENTS374.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.6.6	TEST RESULTS	
4.7.2INSTRUMENTS	4.7	MAXIMUM PEAK OUTPUT POWER	
4.7.3TEST PROCEDURES374.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.1	LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT	
4.7.4DEVIATION FROM TEST STANDARD374.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.2	INSTRUMENTS	
4.7.5TEST SETUP384.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.3	TEST PROCEDURES	
4.7.6EUT OPERATING CONDITION384.7.7TEST RESULTS394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT404.8.2TEST INSTRUMENTS404.8.3TEST PROCEDURE404.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.4	DEVIATION FROM TEST STANDARD	
4.7.6EUT OPERATING CONDITION.384.7.7TEST RESULTS.394.8CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.2TEST INSTRUMENTS.404.8.3TEST PROCEDURE.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION.404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION.436INFORMATION ON THE TESTING LABORATORIES.447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.5	TEST SETUP	
4.8CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.2TEST INSTRUMENTS.404.8.3TEST PROCEDURE.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.6EUT OPERATING CONDITION.404.8.7TEST RESULTS.415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES.447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.6		
4.8CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT.404.8.2TEST INSTRUMENTS.404.8.3TEST PROCEDURE.404.8.4DEVIATION FROM TEST STANDARD.404.8.5TEST SETUP.404.8.6EUT OPERATING CONDITION.404.8.7TEST RESULTS.415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES.447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	4.7.7	TEST RESULTS	
4.8.1LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT	4.8		
4.8.2TEST INSTRUMENTS	4.8.1		-
4.8.3TEST PROCEDURE	-		
4.8.4DEVIATION FROM TEST STANDARD404.8.5TEST SETUP404.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE			
4.8.5TEST SETUP			
4.8.6EUT OPERATING CONDITION404.8.7TEST RESULTS415PHOTOGRAPHS OF THE TEST CONFIGURATION436INFORMATION ON THE TESTING LABORATORIES447APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE	-		-
 4.8.7 TEST RESULTS			
 5 PHOTOGRAPHS OF THE TEST CONFIGURATION			
 6 INFORMATION ON THE TESTING LABORATORIES	-		
7 APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE			



RELEASE CONTROL RECORD

ISSUE NO.	REASON FOR CHANGE	DATE ISSUED
RF120619E04	Original release	July 19, 2012



1 CERTIFICATION

PRODUCT :	Rechargeable Trackpad
BRAND NAME :	Logitech
MODEL NO. :	T-R0003
TEST SAMPLE :	ENGINEERING SAMPLE
APPLICANT :	LOGITECH FAR EAST LTD.
TESTED DATE :	June 20 to July 11, 2012
STANDARDS :	FCC Part 15, Subpart C (Section 15.247)
	ANSI C63.10-2009

The above equipment (Model: T-R0003) has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

: <u>Phonix Huang</u>, **DATE**: <u>July 19, 2012</u> (Phoenix Huang, Specialist) PREPARED BY , DATE: July 19, 2012 APPROVED BY (May Chen, Deputy Manager)



2 SUMMARY OF TEST RESULTS

The EUT has been tested according to the following specifications:

	APPLIED STANDARD: FCC Part 15, Subpart C								
STANDARD SECTION	TEST TYPE AND LIMIT	RESULT	REMARK						
15.207	AC Power Conducted Emission	PASS	Meet the requirement of limit. Minimum passing margin is -17.80dB at 14.67850MHz.						
15.247(a)(1) (iii)	Number of Hopping Frequency Used	PASS	Meet the requirement of limit.						
15.247(a)(1) (iii)	Dwell Time on Each Channel	PASS	Meet the requirement of limit.						
15.247(a)(1)	 Hopping Channel Separation Spectrum Bandwidth of a Frequency Hopping Sequence Spread Spectrum System 	PASS	Meet the requirement of limit.						
15.247(b)	Maximum Peak Output Power	PASS	Meet the requirement of limit.						
15.247(d)	Transmitter Radiated Emissions	PASS	Meet the requirement of limit. Minimum passing margin is -3.3dB at 321.32MHz.						
15.247(d)	Band Edge Measurement	PASS	Meet the requirement of limit.						
15.203	Antenna Requirement	PASS	No antenna connector is used.						

NOTE: Frequency Hopping System operating in 2400-2483.5MHz band and the output power less than 125mW. The hopping channel carrier frequencies separated by a minimum of 25kHz or two-thirds of the 20dB bandwidth of hopping channel whichever is greater.



2.1 MEASUREMENT UNCERTAINTY

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2.

Measurement	Value
Conducted emissions	2.98 dB
Radiated emissions (30MHz-1GHz)	5.59 dB
Radiated emissions (1GHz -6GHz)	3.56 dB
Radiated emissions (6GHz -18GHz)	4.10 dB
Radiated emissions (18GHz -40GHz)	4.24 dB



3 GENERAL INFORMATION

3.1 GENERAL DESCRIPTION OF EUT

PRODUCT	Rechargeable Trackpad
MODEL NO.	T-R0003
POWER SUPPLY	DC 3.7V from battery or
	DC 5V from host equipment
MODULATION TYPE	GFSK
MODULATION TECHNOLOGY	FHSS
DATE RATE	Up to 1Mbps
FREQUENCY RANGE	2402MHz ~ 2480MHz
NUMBER OF CHANNEL	79
MAX. OUTPUT POWER	2.009 mW
ANTENNA TYPE	Inverted F antenna (Gain: -0.47dBi)
DATA CABLE	Micro USB charging cable (shielded, 1.3m) × 1
I/O PORTS	Refer to user's manual
ASSOCIATED DEVICES	NA

NOTE:

1. The EUT must be supplied with one battery, please refer to the following table:

Brand	Model No.	Spec.
Logitech	533-000088 AHB303450	Output: 3.7Vdc Type: Li-polymer

2. The EUT was pre-tested under following test modes :

Mode	Remark
Mode A	Battery Mode
Mode B	USB charging mode + Battery

For the above modes, the worst radiated test was found in **Mode B**. Therefore only the test data of the modes were recorded in this report

3. The above EUT information was declared by the manufacturer and for more detailed feature descriptions, please refer to the manufacturer's specifications or User's Manual.



3.2 DESCRIPTION OF TEST MODES

79 channels are provided for Bluetooth.

Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
0	2402	20	2422	40	2442	60	2462
1	2403	21	2423	41	2443	61	2463
2	2404	22	2424	42	2444	62	2464
3	2405	23	2425	43	2445	63	2465
4	2406	24	2426	44	2446	64	2466
5	2407	25	2427	45	2447	65	2467
6	2408	26	2428	46	2448	66	2468
7	2409	27	2429	47	2449	67	2469
8	2410	28	2430	48	2450	68	2470
9	2411	29	2431	49	2451	69	2471
10	2412	30	2432	50	2452	70	2472
11	2413	31	2433	51	2453	71	2473
12	2414	32	2434	52	2454	72	2474
13	2415	33	2435	53	2455	73	2475
14	2416	34	2436	54	2456	74	2476
15	2417	35	2437	55	2457	75	2477
16	2418	36	2438	56	2458	76	2478
17	2419	37	2439	57	2459	77	2479
18	2420	38	2440	58	2460	78	2480
19	2421	39	2441	59	2461		



3.3 TEST MODE APPLICABLITY AND TESTED CHANNEL DETAIL:

EUT		APF	PLICABLE TO	0		
CONFIGURE MODE	PLC	RE < 1G	RE ³ 1G	APCM	ОВ	DESCRIPTION
-	\checkmark	\checkmark	\checkmark	\checkmark	\checkmark	-
Where PLC: Power Line Conducted Emission RE < 1G: Radiated Emission below 1GHz						ted Emission below 1GHz

RE ³ 1G: Radiated Emission above 1GHz

APCM: Antenna Port Conducted Measurement

OB: Conducted Out-Band Emission Measurement

RADIATED EMISSION TEST (BELOW 1 GHz):

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

		Modulation Technology	Modulation Type	Packet Type
0 to 78	0	FHSS	GFSK	DH1

RADIATED EMISSION TEST (ABOVE 1 GHz):

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

Available	Tested	Modulation	Modulation	Packet Type	
Channel	Channel	Technology	Type		
0 to 78	0, 39, 78	FHSS	GFSK	DH1	

ANTENNA PORT CONDUCTED MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

Available Channel	Tested Channel	Modulation Technology	Modulation Type	Packet Type
0 to 78	0, 39, 78	FHSS	GFSK	DH1



CONDUCTED OUT-BAND EMISSION MEASUREMENT:

- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

Available	Tested	Modulation	Modulation	Packet Type
Channel	Channel	Technology	Type	
0 to 78	0, 78	FHSS	GFSK	DH1

TEST CONDITION:

APPLICABLE TO	ENVIRONMENTAL CONDITIONS	INPUT POWER (SYSTEM)	TESTED BY	
PLC	26deg. C, 61%RH,	120Vac, 60Hz	Scott Chen	
RE<1G	22deg. C, 64%RH	120Vac, 60Hz	Robert Cheng	
RE ³ 1G	21deg. C, 62%RH	120Vac, 60Hz	Robert Cheng	
APCM	25deg. C, 60%RH	120Vac, 60Hz	Wen yu	
ОВ	25deg. C, 60%RH	120Vac, 60Hz	Wen yu	



3.4 GENERAL DESCRIPTION OF APPLIED STANDARDS

The EUT is a RF product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC Part 15, Subpart C. (15.247)

ANSI C63.10-2009

All test items have been performed and recorded as per the above standards.



3.5 DESCRIPTION OF SUPPORT UNITS

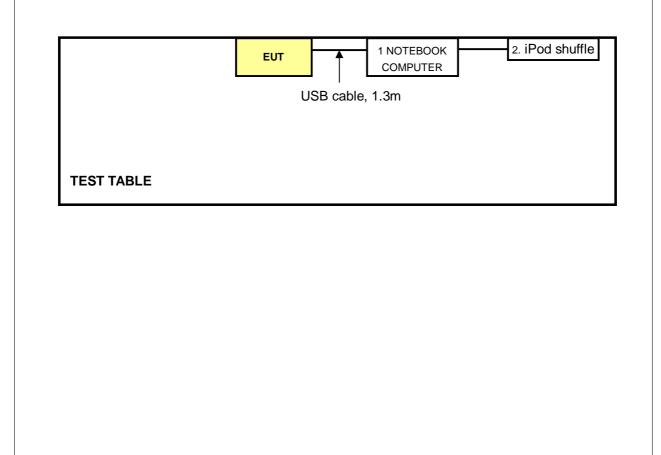
The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

NO.	PRODUCT	BRAND	MODEL NO.	SERIAL NO.	FCC ID
1	NOTEBOOK COMPUTER	DELL	PP32LA	GSLB32S	FCC DoC
2	iPod shuffle	Apple	MC749TA/A	CC4DMFJUDFD M	NA

NO.	SIGNAL CABLE DESCRIPTION OF THE ABOVE SUPPORT UNITS
1	USB cable, 1.3m
2	USB cable, 0.1m

NOTE: All power cords of the above support units are non shielded (1.8m).

3.6 CONFIGURATION OF SYSTEM UNDER TEST





4 TEST PROCEDURES AND RESULTS

4.1 CONDUCTED EMISSION MEASUREMENT

4.1.1 LIMITS OF CONDUCTED EMISSION MEASUREMENT

FREQUENCY OF EMISSION (MHz)	z) CONDUCTED LIMIT (dBµV)		
	Quasi-peak	Average	
0.15 ~ 0.5	66 to 56	56 to 46	
0.5 ~ 5	56	46	
5 ~ 30	60	50	

NOTE: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50MHz.

4.1.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
Test Receiver ROHDE & SCHWARZ	ESCS 30	100287	Feb. 29, 2012	Feb. 28, 2013
Line-Impedance Stabilization Network (for EUT) SCHWARZBECK	NSLK 8127	8127-523	Sep. 20, 2011	Sep. 19, 2012
Line-Impedance Stabilization Network (for Peripheral) ROHDE & SCHWARZ	ESH3-Z5	848773/004	Nov. 01, 2011	Oct. 31, 2012
RF Cable (JYEBAO)	5DFB	COACAB-002	Aug. 06, 2011	Aug. 05, 2012
50 ohms Terminator	50	4	Nov. 12, 2011	Nov. 11, 2012
Software ADT	BV ADT_Cond_V7.3.7 .3	NA	NA	NA

Note:

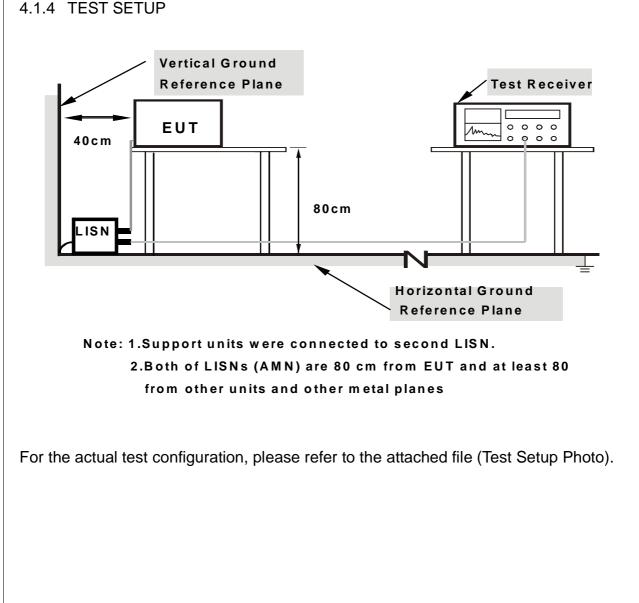
1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The test was performed in Shielded Room No. A.
- 3 The VCCI Con A Registration No. is C-817.
- 4. Tested Date: July 07, 2012



4.1.3 TEST PROCEDURES

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150kHz to 30MHz was searched. Emission levels under (Limit 20dB) was not recorded.





4.1.5 EUT OPERATING CONDITIONS

- 1. Connect the EUT with the support unit 1 (Notebook Computer) which is placed in test table.
- 2. Controlling software (Button Function) has been activated to set the EUT on specific status.

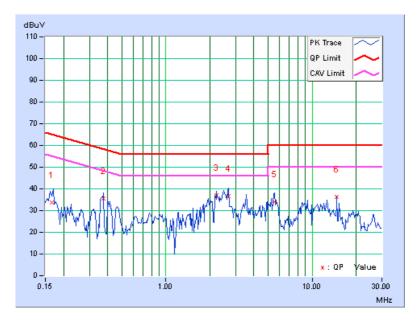


4.1.6 TEST RESULTS

PHASE Line (L) 6dB BAND			DWIDTH	9 kHz						
	Freq.	Corr.	Readin	a Value	Emissi	on Level	Lir	nit	Ma	rgin
No		Factor				(uV)] [dB (uV)]		(dB)		
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.16699	0.07	33.69	23.58	33.76	23.65	65.11	55.11	-31.35	-31.46
2	0.37284	0.08	35.42	23.85	35.50	23.93	58.44	48.44	-22.94	-24.51
3	2.21625	0.21	36.72	27.89	36.93	28.10	56.00	46.00	-19.07	-17.90
4	2.67898	0.24	36.33	23.82	36.57	24.06	56.00	46.00	-19.43	-21.94
5	5.55385	0.37	33.62	24.67	33.99	25.04	60.00	50.00	-26.01	-24.96
6	14.67850	0.68	35.55	31.52	36.23	32.20	60.00	50.00	-23.77	-17.80

REMARKS:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.

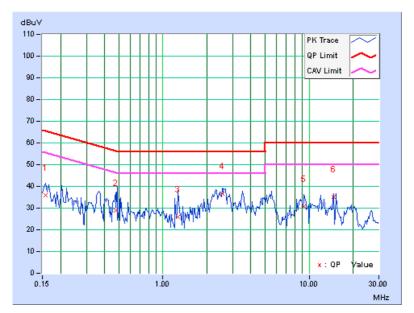




PHASE			utral (N)			6dB BANDWIDTH		9 kHz	9 kHz	
	Freq.	Corr.	Readin	g Value	Emissi	on Level	Lir	nit	Ma	rgin
No		Factor	[dB	(uV)]	[dB (uV)]		[dB (uV)]		(dB)	
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15856	0.06	35.76	25.11	35.82	25.17	65.54	55.54	-29.72	-30.37
2	0.47688	0.08	28.67	22.23	28.75	22.31	56.39	46.39	-27.64	-24.08
3	1.26875	0.11	25.66	16.91	25.77	17.02	56.00	46.00	-30.23	-28.98
4	2.55255	0.19	36.32	26.89	36.51	27.08	56.00	46.00	-19.49	-18.92
5	9.23215	0.37	30.33	24.48	30.70	24.85	60.00	50.00	-29.30	-25.15
6	14.67298	0.55	34.56	30.41	35.11	30.96	60.00	50.00	-24.89	-19.04

REMARKS:

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.





4.2 RADIATED EMISSION AND BANDEDGE MEASUREMENT

4.2.1 LIMITS OF RADIATED EMISSION AND BANDEDGE MEASUREMENT

Radiated emissions which fall in the restricted bands must comply with the radiated emission limits specified as below table. Other emissions shall be at least 20dB below the highest level of the desired power:

FREQUENCIES (MHz)	FIELD STRENGTH (microvolts/meter)	MEASUREMENT DISTANCE (meters)
0.009 ~ 0.490	2400/F(kHz)	300
0.490 ~ 1.705	24000/F(kHz)	30
1.705 ~ 30.0	30	30
30 ~ 88	100	3
88 ~ 216	150	3
216 ~ 960	200	3
Above 960	500	3

NOTE:

- 1. The lower limit shall apply at the transition frequencies.
- 2. Emission level (dBuV/m) = 20 log Emission level (uV/m).
- 3. For frequencies above 1000MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20dB under any condition of modulation.



4.2.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
Spectrum Analyzer Agilent	E4446A	MY48250254	July 12, 2011	July 11, 2012
Pre-Selector Agilent	N9039A	MY46520311	July 12, 2011	July 11, 2012
Signal Generator Agilent	N5181A	MY49060517	July 12, 2011	July 11, 2012
Pre-Amplifier Mini-Circuits	ZFL-1000VH2 B	AMP-ZFL-03	Nov. 15, 2011	Nov. 14, 2012
Pre-Amplifier Agilent	8449B	3008A02578	June 26, 2012	June 25, 2013
Pre-Amplifier SPACEK LABS	SLKKa-48-6	9K16	Nov. 15, 2011	Nov. 14, 2012
Trilog Broadband Antenna SCHWARZBECK	VULB 9168	9168-360	Apr. 09, 2012	Apr. 08, 2013
Horn_Antenna AISI	AIH.8018	0000320091110	Nov. 14, 2011	Nov. 13, 2012
Horn_Antenna SCHWARZBECK	BBHA 9170	9170-424	Oct. 07, 2011	Oct. 06, 2012
RF Cable	NA	RF104-201 RF104-203 RF104-204	Dec. 26, 2011	Dec. 25, 2012
RF Cable	NA	CHGCAB_001	Oct. 07, 2011	Oct. 06, 2012
Software	ADT_Radiated _V8.7.05	NA	NA	NA
Antenna Tower & Turn Table CT	NA	NA	NA	NA

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. The horn antenna, preamplifier (model: 8449B) are used only for the measurement of emission frequency above 1GHz if tested.
- 3 The test was performed in 966 Chamber No. G.
- 4. The FCC Site Registration No. is 966073.
- 5 The VCCI Site Registration No. is G-137.
- 6 The CANADA Site Registration No. is IC 7450H-2.
- 7 Tested Date: July 11, 2012



4.2.3 TEST PROCEDURES

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meters chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz.

NOTE:

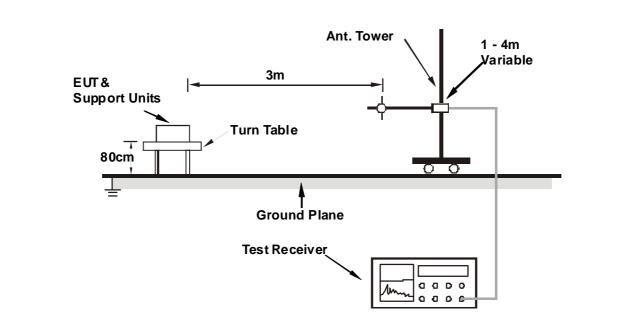
- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and video bandwidth is 1MHz for Peak detection at frequency above 1GHz.
- 3. All modes of operation were investigated and the worst-case emissions are reported.

4.2.4 DEVIATION FROM TEST STANDARD

No deviation



4.2.5 TEST SETUP



For the actual test configuration, please refer to the related item – Photographs of the Test Configuration.

4.2.6 EUT OPERATING CONDITIONS

Same as 4.1.6



4.2.7 TEST RESULTS

BELOW 1GHz WORST-CASE DATA

BT_GFSK

CHANNEL	TX Channel 0	DETECTOR	Oursei Deals (OD)
FREQUENCY RANGE	Below 1GHz	FUNCTION	Quasi-Peak (QP)

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M							
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	149.13	35.3 QP	43.5	-8.2	1.50 H	229	20.35	14.91
2	238.66	40.4 QP	46.0	-5.6	1.00 H	297	27.52	12.85
3	320.85	42.2 QP	46.0	-3.8	1.00 H	162	26.37	15.83
4	338.96	38.1 QP	46.0	-7.9	1.00 H	122	21.83	16.30
5	478.94	39.1 QP	46.0	-6.9	2.00 H	172	19.20	19.86
6	609.21	32.7 QP	46.0	-13.3	1.00 H	266	9.90	22.78
		ANTENNA		/ & TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	55.58	33.2 QP	40.0	-6.8	1.00 V	340	19.38	13.84
2	243.52	36.6 QP	46.0	-9.4	2.00 V	198	23.54	13.07
3	321.32	42.7 QP	46.0	-3.3	1.50 V	206	26.86	15.84
4	478.47	35.6 QP	46.0	-10.4	1.50 V	144	15.76	19.85
5	609.21	35.9 QP	46.0	-10.2	1.50 V	201	13.07	22.78
6	798.92	30.2 QP	46.0	-15.9	1.50 V	104	4.25	25.90

REMARKS:

1. Emission level (dBuV/m) = Raw Value (dBuV) + Correction Factor (dB/m).

2. Correction Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB).

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.



ABOVE 1GHz DATA

BT_GFSK

CHANNEL	TX Channel 0	DETECTOR FUNCTION	Deals (DK)
FREQUENCY RANGE	1GHz ~ 25GHz		Peak (PK)

		ANTENNA I	POLARITY	& TEST DIS	TANCE: HO	RIZONTAL	AT 3 M	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	2390.00	55.8 PK	74.0	-18.2	1.15 H	321	23.61	32.19
2	2390.00	11.7 AV	54.0	-42.3	1.15 H	321	-20.49	32.19
3	*2402.00	95.9 PK			1.15 H	321	63.68	32.22
4	*2402.00	51.8 AV			1.15 H	321	19.58	32.22
5	4804.00	48.1 PK	74.0	-25.9	1.08 H	195	6.56	41.54
6	4804.00	4.0 AV	54.0	-50.0	1.08 H	195	-37.54	41.54
		ANTENNA		/ & TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	2390.00	55.9 PK	74.0	-18.1	1.00 V	91	23.71	32.19
2	2390.00	11.8 AV	54.0	-42.2	1.00 V	91	-20.39	32.19
3	*2402.00	94.0 PK			1.00 V	91	61.78	32.22
4	*2402.00	49.9 AV			1.00 V	91	17.68	32.22
5	4804.00	47.5 PK	74.0	-26.5	1.10 V	252	5.96	41.54
6	4804.00	3.4 AV	54.0	-50.6	1.10 V	252	-38.14	41.54

REMARKS:

1. Emission level (dBuV/m) = Raw Value (dBuV) + Correction Factor (dB/m).

2. Correction Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB).

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.

5. " * ": Fundamental frequency.

6. The DH1 packet was the worse case duty cycle for a transmit dwell time on a channel, based upon bluetooth theory the transmitter is on 0.625×1 per 98.75 ms per channel. Therefore, the duty cycle correlation factor be equal to: $20\log(0.625 / 100) = -44.1$ dB.

7. Average value = peak reading + 20log(duty cycle).



CHANNEL	TX Channel 39	DETECTOR	Deals (DK)		
FREQUENCY RANGE	1GHz ~ 25GHz	FUNCTION	Peak (PK)		

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M							
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2441.00	97.1 PK			1.14 H	327	64.78	32.32
2	*2441.00	53.0 AV			1.14 H	327	20.68	32.32
3	4882.00	48.2 PK	74.0	-25.8	1.11 H	191	6.52	41.68
4	4882.00	4.1 AV	54.0	-49.9	1.11 H	191	-37.58	41.68
5	7323.00	53.1 PK	74.0	-20.9	1.00 H	213	6.93	46.17
6	7323.00	9.0 AV	54.0	-45.0	1.00 H	213	-37.17	46.17
		ANTENNA	A POLARIT	/ & TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2441.00	95.1 PK			1.00 V	93	62.78	32.32
2	*2441.00	51.0 AV			1.00 V	93	18.68	32.32
3	4882.00	47.7 PK	74.0	-26.3	1.10 V	253	6.02	41.68
4	4882.00	3.6 AV	54.0	-50.4	1.10 V	253	-38.08	41.68
5	7323.00	53.1 PK	74.0	-20.9	1.02 V	133	6.93	46.17
6	7323.00	9.0 AV	54.0	-45.0	1.02 V	133	-37.17	46.17

REMARKS:

1. Emission level (dBuV/m) = Raw Value (dBuV) + Correction Factor (dB/m).

2. Correction Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB).

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.

5. " * ": Fundamental frequency.

6. The DH1 packet was the worse case duty cycle for a transmit dwell time on a channel, based upon bluetooth theory the transmitter is on 0.625 * 1 per 98.75 ms per channel. Therefore, the duty cycle correlation factor be equal to: $20\log(0.625 / 100) = -44.1$ dB. 7. Average value = peak reading + $20\log(duty cycle)$.



CHA	NNEL			DETECTOR		Deels (DK)			
FRE				<u>.</u>	FUNCTION		Peak (PK)		
	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M								
NO.	FREQ. (MHz)	EMISSIC LEVEI (dBuV/I	L	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2480.00	98.1 P	К			1.08 H	325	65.68	32.42
2	*2480.00	54.0 A	V			1.08 H	325	21.58	32.42
3	2483.50	56.2 P	K	74.0	-17.8	1.08 H	325	23.77	32.43
4	2483.50	12.1 A	V	54.0	-41.9	1.08 H	325	-20.33	32.43
5	4960.00	48.4 P	K	74.0	-25.6	1.09 H	178	6.72	41.68
6	4960.00	4.3 AV	/	54.0	-49.7	1.09 H	178	-37.38	41.68
7	7440.00	53.4 P	K	74.0	-20.6	1.00 H	215	6.97	46.43
8	7440.00	9.3 AV	/	54.0	-44.7	1.00 H	215	-37.13	46.43
		ANTE	NNA	POLARITY	& TEST	DISTANCE: V	ERTICAL A	T 3 M	
NO.	FREQ. (MHz)	EMISSIC LEVEI (dBuV/I	L	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2480.00	96.1 P	K			1.00 V	94	63.68	32.42
2	*2480.00	52.0 A	V			1.00 V	94	19.58	32.42
3	2483.50	55.8 P	K	74.0	-18.2	1.00 V	94	23.37	32.43
4	2483.50	11.7 A	V	54.0	-42.3	1.00 V	94	-20.73	32.43
5	4960.00	47.9 P	K	74.0	-26.1	1.10 V	262	6.22	41.68
6	4960.00	3.8 AV	/	54.0	-50.2	1.10 V	262	-37.88	41.68
7	7440.00	53.1 P	K	74.0	-20.9	1.00 V	125	6.67	46.43
8	7440.00	9.0 AV	/	54.0	-45.0	1.00 V	125	-37.43	46.43

REMARKS:

1. Emission level (dBuV/m) = Raw Value (dBuV) + Correction Factor (dB/m).

2. Correction Factor (dB/m) = Antenna Factor (dB/m) + Cable Factor (dB).

3. The other emission levels were very low against the limit.

4. Margin value = Emission level – Limit value.

5. " * ": Fundamental frequency.

6. The DH1 packet was the worse case duty cycle for a transmit dwell time on a channel, based upon bluetooth theory the transmitter is on 0.625×1 per 98.75 ms per channel. Therefore, the duty cycle correlation factor be equal to: $20\log(0.625 / 100) = -44.1$ dB.

7. Average value = peak reading + 20log(duty cycle).



4.3 NUMBER OF HOPPING FREQUENCY USED

4.3.1 LIMIT OF HOPPING FREQUENCY USED

At least 15 hopping frequencies, and should be equally spaced.

4.3.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S SPECTRUM ANALYZER	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

4.3.3 TEST PROCEDURES

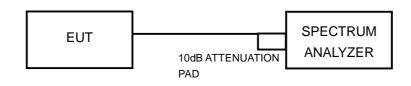
- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Set the SA on MaxHold Mode, and then keep the EUT in hopping mode. Record all the signals from each channel until each one has been recorded.
- d. Set the SA on View mode and then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.3.4 DEVIATION FROM TEST STANDARD

No deviation

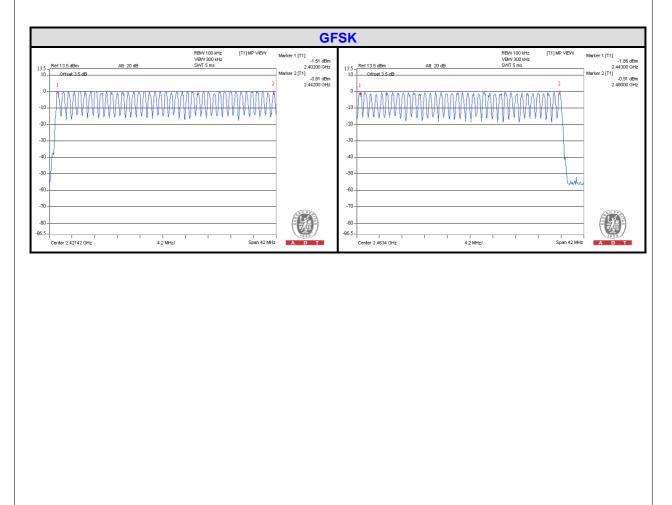


4.3.5 TEST SETUP



4.3.6 TEST RESULTS

There are 79 hopping frequencies in the hopping mode. Please refer to next pages for the test result. On the plots, it shows that the hopping frequencies are equally spaced.





4.4 DWELL TIME ON EACH CHANNEL

4.4.1 LIMIT OF DWELL TIME USED

The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.

4.4.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S Spectrum Analyzer	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

4.4.3 TEST PROCEDURES

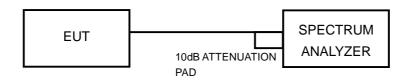
- a. Check the calibration of the measuring instrument (SA) using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect its antenna terminal to measurement via a low loss cable. Then set it to any one measured frequency within its operating range and make sure the instrument is operated in its linear range.
- c. Adjust the center frequency of SA on any frequency be measured and set SA to zero span mode. And then, set RBW and VBW of spectrum analyzer to proper value.
- d. Measure the time duration of one transmission on the measured frequency. And then plot the result with time difference of this time duration.
- e. Repeat above procedures until all different time-slot modes have been completed.



4.4.4 DEVIATION FROM TEST STANDARD

No deviation

4.4.5 TEST SETUP





4.4.6 TEST RESULTS

Mode	Number of transmission in a 31.6 (79Hopping*0.4)	Length of transmission time (msec)	Result (msec)	Limit (msec)
DH1	51 (times / 5 sec) *6.32=322.32 times	0.492	158.58	400
IOTE: Tes	t plots of the transmitting time slot are sho	wn as below.		
	DH1 RBW 100 kHz [T1] MP CLRWR		RBW 100 kHz	[T1] MP VIEW Marker 1 (T1)
Ref 13.5 dBm Offset 3.5 dB	VBW100 btz (11) m Clow (12) 13 14 15 15 13 13 14 15 14 15 15 13 13 11 11 11 11 11 11 11 11 11 11 11	Ref 13.5 dBm Att 20 dB	VBW100 kHz SWT3 ms	-66.22 1.23600 Deta 2 [T1]
			N	3.3 492.0000
			MANN	
	<u>,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,</u>			
an an An An An An Na Tanàna Ang Ang	an A.)-		
andin karinda a ana kanadin Dani. Ka	-3) 2.10 to different install and not start at the start of the start induced lifet sour difference of the start -0	AMMAN MANANAN AMMAN	MMMMMMM	WMART AMA
		11110001000	I to should be	
Center 2.441 GHz	-86. 500 ms/	Center 2.441 GHz	1 1 1 300 us/	A D T



4.5 CHANNEL BANDWIDTH

4.5.1 LIMITS OF CHANNEL BANDWIDTH

For frequency hopping system operating in the 2400-2483.5MHz, If the 20dB bandwidth of hopping channel is greater than 25kHz, two-thirds 20dBbandwidth of hopping channel shell be a minimum limit for the hopping channel separation.

4.5.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S Spectrum Analyzer	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

4.5.3 TEST PROCEDURE

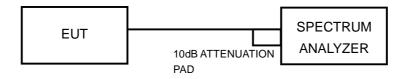
- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. Measure the frequency difference of two frequencies that were attenuated 20dB from the reference level. Record the frequency difference as the emission bandwidth.
- d. Repeat above procedures until all frequencies measured were complete.

4.5.4 DEVIATION FROM TEST STANDARD

No deviation



4.5.5 TEST SETUP



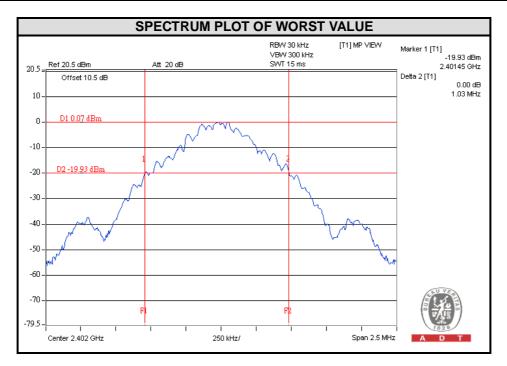
4.5.6 EUT OPERATING CONDITION

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.5.7 TEST RESULTS

CHANNEL	FREQUENCY (MHz)	20dB BANDWIDTH (MHz)
0	2402	1.03
39	2441	1.03
78	2480	1.03





4.6 HOPPING CHANNEL SEPARATION

4.6.1 LIMIT OF HOPPING CHANNEL SEPARATION

At least 25 kHz or two-thirds of 20dB hopping channel bandwidth (whichever is greater).

4.6.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S Spectrum Analyzer	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

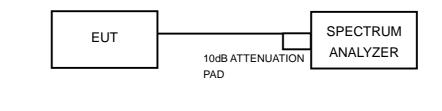
4.6.3 TEST PROCEDURES

- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range.
- c. By using the MaxHold function record the separation of two adjacent channels.
- d. Measure the frequency difference of these two adjacent channels by SA MARK function. And then plot the result on SA screen.
- e. Repeat above procedures until all frequencies measured were complete.

4.6.4 DEVIATION FROM TEST STANDARD

No deviation

4.6.5 TEST SETUP

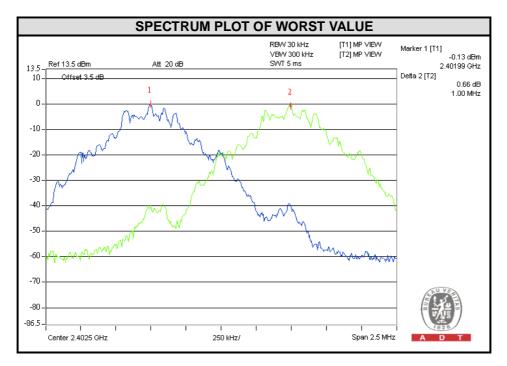




4.6.6 TEST RESULTS

CHANNEL	FREQUENCY (MHz)	ADJACENT CHANNEL SEPARATION (MHz)	20dB BANDWIDTH (MHz)	MINIMUM LIMIT (MHz)	PASS / FAIL
0	2402	1.00	1.03	0.69	PASS
39	2441	1.01	1.03	0.69	PASS
78	2480	1.00	1.03	0.69	PASS

NOTE: The minimum limit is two-third 20dB bandwidth.





4.7 MAXIMUM PEAK OUTPUT POWER

4.7.1 LIMITS OF MAXIMUM PEAK OUTPUT POWER MEASUREMENT

The Maximum Peak Output Power Limit is 125mW.

4.7.2 INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S Spectrum Analyzer	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

4.7.3 TEST PROCEDURES

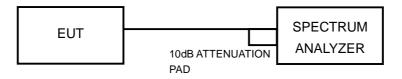
- a. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
- c. The center frequency of the spectrum analyzer is set to the fundamental frequency and using 3MHz RBW and 10 MHz VBW.
- d. Measure the captured power within the band and recording the plot.
- e. Repeat above procedures until all frequencies required were complete.

4.7.4 DEVIATION FROM TEST STANDARD

No deviation



4.7.5 TEST SETUP



For the actual test configuration, please refer to the related Item – Photographs of the Test Configuration.

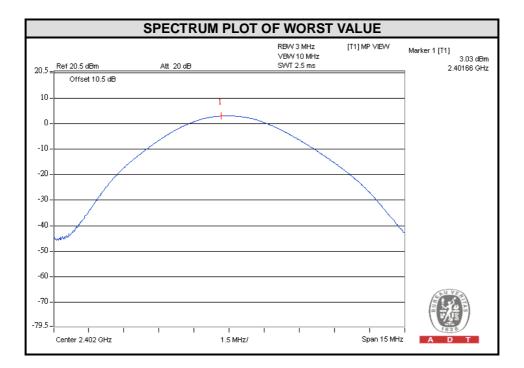
4.7.6 EUT OPERATING CONDITION

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.7.7 TEST RESULTS

CHANNEL	FREQUENCY (MHz)	OUTPUT POWER (mW)	OUTPUT POWER (dBm)	POWER LIMIT (mW)	PASS / FAIL
0	2402	2.009	3.03	125	PASS
39	2441	1.991	2.99	125	PASS
78	2480	1.845	2.66	125	PASS





4.8 CONDUCTED OUT-BAND EMISSION MEASUREMENT

4.8.1 LIMITS OF CONDUCTED OUT-BAND EMISSION MEASUREMENT

Below –20dB of the highest emission level of operating band (in 100kHz RBW).

4.8.2 TEST INSTRUMENTS

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
R&S Spectrum Analyzer	FSP40	100036	Dec. 14, 2011	Dec. 13, 2012

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

2. Tested date : July 10, 2012

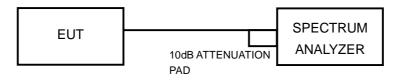
4.8.3 TEST PROCEDURE

The transmitter output was connected to the spectrum analyzer via a low lose cable. Set RBW a of spectrum analyzer to 100 kHz and VBW of spectrum analyzer to 300 kHz with suitable frequency span including 100 MHz bandwidth from band edge. The band edges was measured and recorded.

4.8.4 DEVIATION FROM TEST STANDARD

No deviation

4.8.5 TEST SETUP



4.8.6 EUT OPERATING CONDITION

The software provided by client enabled the EUT to transmit and receive data at lowest, middle and highest channel frequencies individually.



4.8.7 TEST RESULTS

The spectrum plots are attached on the following images. D1 line indicates the highest level, and D2 line indicates the 20dB offset below D1. It shows compliance with the requirement.



GFSK Hopping disabled_ Low Channel RBW 100 kHz VBW 300 kHz SWT 2.5 s RBW 100 kHz VBW 300 kHz SWT 20 ms [T1] MP VIEW Marker 1 [T1] rker 1 [T1] 2.13 dBm 2.40207 GHz rker 2 [T1] -51.25 dBm 2.4000 GHz rker 3 [T1] 2.39280 GHz rker 4 [T1] ker 1 [T1] Marker 1 [T1] 1.24 dBm 2.40215 GHz Marker 2 [T1] -45.99 dBm 15.17431 GHz Marker 3 [T1] -46.15 dBm 2.57070 GHz Marker 4 [T1] -46.19 dBm Ref 30.5 dBm Offset 10.5 dB Att 20 dt 30.5 _ Ref 30.5 dBm Offset 10.5 dB Att 20 d 30.5 20 20 10 10 2.39280 GHz Marker 4 [T1] -51.50 dBm 2.39000 GHz Marker 5 [T1] -46.24 dBm 2.33677 GHz D1 2 13 dBm D1 2.13 dBm -46.19 dBm 48.73 MHz 0 0 -10 -10 D2 -17.87 dBm D2 -17 87 dBn -20 -20 - 30 -30 -40 -41 -50 -50 -60 -60 F -69.5 --69.5 I Stop 25 GH nter 2.358 GHz 10 MHz/ 1 2.497 GHz/ Start 30 MHz Hopping disabled_ High Channel Merker 1 [71] 2.02 dBm 2.47998 OHz Marker 2 [71] -50 98 dBm 2.48350 OHz Marker 3 [71] -4.6.02 dBm 2.48922 OHz Merker 4 [71] -49.74 dBm 2.50000 OHz Marker 1 [T1] 1.53 dBm 2.47706 GHz Marker 2 [T1] -45.56 dBm 4.49339 GHz Marker 3 [T1] -15.62 dBm 17.50852 GHz Marker 4 [T1] -45.04 dBm 23.78271 GHz RBW 100 kHz VBW 300 kHz SWT 20 ms [T1] MP VIEW RBW 100 kHz VBW 300 kHz SWT 2.5 s [T1] MP VIEW Ref 30.5 dBr Att 20 dE Att 20 dB 30.5 10.5 dE Offset 20 20 10 1 D1 2 02 dBn D1 2.02 dBn 0 -10 -10 D2-179 D2 -17.98 -20 --20 -30 -30 11 -40 -40 --50 -50--60 -60 -69.5. -69.5 1 10 MHz/ I Span 100 MH Start 30 MHz 1 2.497 GHz/ I Stop 25 GHz Center 2.5242 GHz Hopping enabled_ Low Channel Marker 1 [T1] 1.24 dBm 2.40215 GHz Marker 2 [T1] -45.99 dBm 15.17431 GHz Marker 3 [T1] -46.15 dBm 2.57070 GHz Marker 4 [T1] -46.19 dBm 48.73 MHz RBW 100 kHz VBVV 300 kHz SWT 20 ms RBW 100 kHz VBW 300 kHz SWT 2.5 s IT11 MP VIEW IT11 MP VIEW Marker 1 [T1] 30.5 = Ref 30.5 dBm Offset 10.5 dB Ref 23.5 dBm Att 20 c 23.5 1] -55.70 dBm 2.40000 GHz 20 10 10 D1 0.02 dBn 0 1] -56.64 dBm 2.39000 GHz D1 2.13 dBm 0 -10 5 [T1] -53.70 dBm 2.38548 GHz -10 D2 -19.98 dBm -20 D2 -17 87 dE -20 -30 -30 -40 -40 -50 -50 -60 -60 -70 -76.5 --69.5 I Span 140 Mł I Center 2.358 GHz 14 MHz/ l 2.497 GHz/ Start 30 MHz I Stop 25 GHz Hopping enabled_ High Channel RBW 100 kHz VBW 300 kHz SWT 20 ms RBW 100 kHz VBW 300 kHz SWT 2.5 s [T1] MP VIEW IT11 MP VIEW Marker 1 [T1] arker 1 [11] -0.08 dBm 2.46498 OHz -56.20 dBm 2.46350 OHz arker 3 [11] 2.49595 OHz arker 4 [1] -55.57 dBm 2.50000 GHz Marker 1 [T1] Marker 1 [71] 2.47706 OHz 2.47706 OHz 4.43339 OHz Marker 2 [71] 4.43339 OHz Marker 3 [71] -45.62 dBm 17.90852 OHz Marker 4 [71] -46.04 dBm 23.78271 OHz 23.5 - Ref 23.5 dBr 20 - Officer ? 30.5 _ Ref 30.5 dBm Offset 10.5 dB Offset 3.5 20 10 10 0 **MARIAN** _____1 _____12_02_4E 0 -10 Di Sanala -10 -20 D2 -17.9 -20 -30 -30 -40 -40 -50 -50 -60 -61 -70 --69.5 -76.5 -I Span 140 MHz 1 2.497 GHz/ Stop 25 GHz Center 2.5242 GHz 14 MHz/ A Start 30 MHz A



5 PHOTOGRAPHS OF THE TEST CONFIGURATION

Please refer to the attached file (Test Setup Photo).



6 INFORMATION ON THE TESTING LABORATORIES

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab: Tel: 886-2-26052180 Fax: 886-2-26052943 Hsin Chu EMC/RF Lab: Tel: 886-3-5935343 Fax: 886-3-5935342

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Email: <u>service.adt@tw.bureauveritas.com</u> Web Site: <u>www.adt.com.tw</u>

The address and road map of all our labs can be found in our web site also.



7 APPENDIX A - MODIFICATIONS RECORDERS FOR ENGINEERING CHANGES TO THE EUT BY THE LAB

No modifications were made to the EUT by the lab during the test.

--- END ----